

### Technical Data

NCC Series



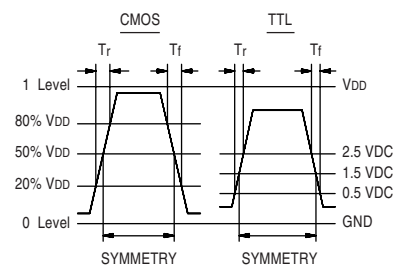
#### Description

A crystal controlled, low current hybrid oscillator providing precise rise and fall times to drive CMOS and NMOS microprocessors. Compatible with both CMOS and TTL. Can drive up to 2 LSTTL loads. Device is packaged in 14-pin or an 8-pin DIP compatible full size or half size, resistance welded, all metal case. Pin 7 (pin 4 for 1/2 size) is grounded to the case to reduce RFI.

#### Applications & Features

- Low power
- CMOS and TTL compatible output
- Grounded, all metal full size and half size case
- See NTH Series for Tri-State on pin 1
- Gull Wing packages compatible with standard reflow processes

#### Output Waveform



<b>Frequency Range:</b>	500 kHz to 24 MHz	
<b>Frequency Stability:</b>	±25, ±50 or ±100 ppm over all conditions: calibration tolerance, operating temperature, input voltage change, load change, *aging, shock and vibration.	
<b>*Aging</b>	30 days	
<b>Temperature Range:</b>	Operating: 0°C to +70°C Storage: -55°C to +125°C	
<b>Supply Voltage:</b>	Recommended Operating: 5V ±10%	
<b>Supply Current:</b>	(See Input Current vs. Frequency Graph, page 2)	
<b>Output Drive:</b>		
<u>CMOS</u>	Symmetry	see part numbering guide
	Rise & Fall Times:	12ns max, 20% to 80% VDD
	Logic 0:	10% VDD max
	Logic 1:	90% VDD min
	Output Load:	2 CMOS
<u>TTL</u>	Symmetry	see part numbering guide
	Rise & Fall Times:	12ns max, 0.5V to 2.5V
	Logic 0:	0.5V max
	Logic 1:	2.5V min (VCC -0.6 typ)
	Output Load:	2 LSTTL
<b>Mechanical:</b>		
	Shock:	MIL-STD-883, Method 2002, Condition B
	Solderability:	MIL-STD-883, Method 2003
	Terminal Strength:	MIL-STD-883, Method 2004, Condition B2
	Vibration:	MIL-STD-883, Method 2007, Condition A
	Solvent Resistance:	MIL-STD-202, Method 215
	Resistance to Soldering Heat:	MIL-STD-202, Method 210, Condition A, B or C
<b>Environmental:</b>		
	Gross Leak Test:	MIL-STD-883, Method 1014, Condition C
	Fine Leak Test:	MIL-STD-883, Method 1014, Condition A2
	Thermal Shock:	MIL-STD-883, Method 1011, Condition A
	Moisture Resistance:	MIL-STD-883, Method 1004

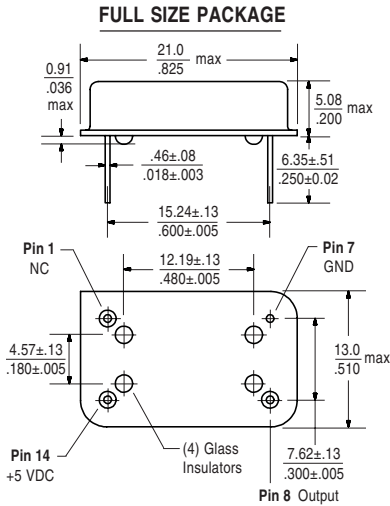
#### Part Numbering Guide

<b>Series</b>	NCC 0 6 0 C	<b>Frequency (MHz)</b>	- 4.0000
<b>Symmetry &amp; Temperature Range</b>		<b>Blank</b>	= No Enable/Disable
0	= 40/60% max, 0 to 70°C	<b>Stability Tolerance</b>	A = ±25 ppm, 0 to +70°C only
2	= 40/60% max, -40 to 85°C		B = ±50 ppm
4	= 45/55% max, -40 to 85°C, TTL to 7.1590MHz		C = ±100 ppm
6	= 45/55% max, 0 to 70°C, TTL to 7.1590MHz	<b>Package Type</b>	0 = Full Size
A	= 45/55% max, 0 to 70°C, CMOS to 7.1590MHz		9 = Half Size
C	= 45/55% max, -40 to 85°C, CMOS to 7.1590MHz		K = Full Size, Gull Wing
			J = Half Size, Gull Wing
<b>Frequency Range</b>			
3	= 500 kHz ~ 3.9999 MHz		
6	= 4 MHz to 24 MHz		

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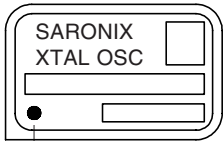
NCC Series

#### Package Details

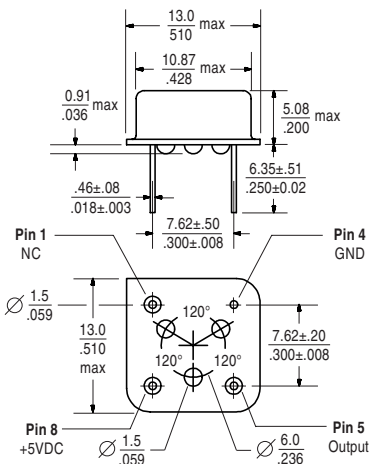


**Marking Format \***

Includes Date Code, Frequency & Model



**HALF SIZE PACKAGE**



**Marking Format \***

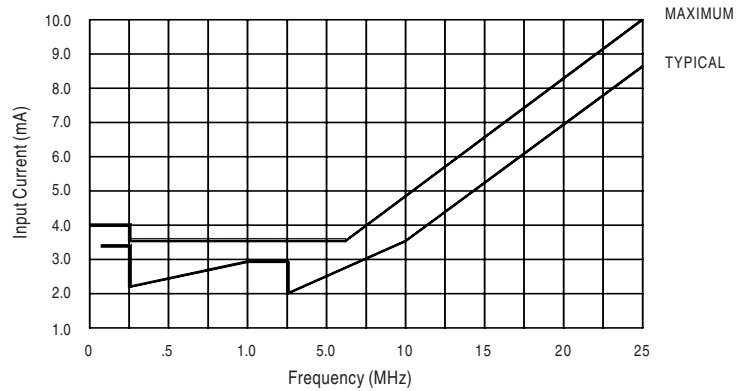
Includes Date Code, Frequency & Model



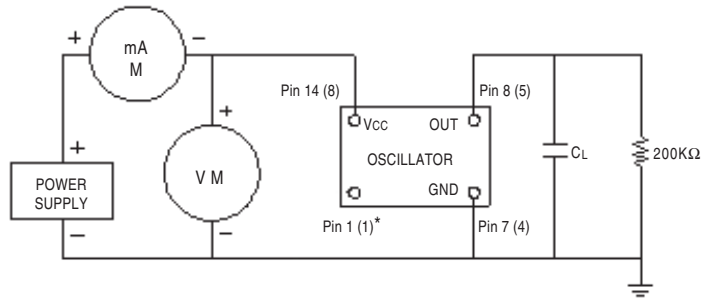
\* Exact location of items may vary

Scale: None (Dimensions in  $\frac{mm}{inches}$ )

#### Input Current vs. Frequency at +5.0V

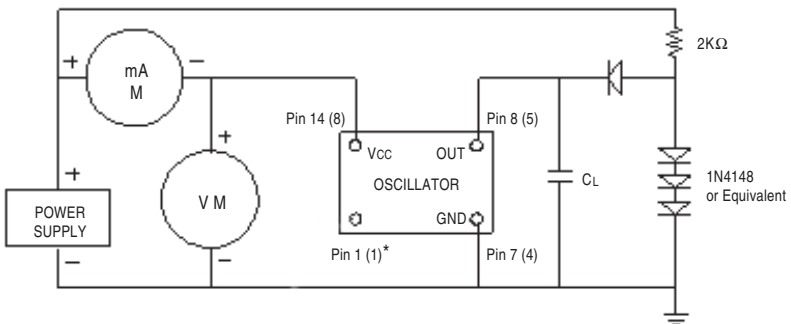


#### Test Circuits



NOTE:  
 $C_L = 15 \text{ pF}$  max (Includes probe and fixture capacitance)  
 Pin 1 = No connection.  
 \* ( ) Indicates pin numbers for half-size package

**CMOS TEST CIRCUIT**



NOTE:  
 $C_L = 15 \text{ pF}$  max (Includes probe and fixture capacitance)  
 Pin 1 = No connection.  
 \* ( ) Indicates pin numbers for half-size package

**TTL TEST CIRCUIT**

All specifications are subject to change without notice.